

IGBT4 Medium Power Chip

FEATURES:

- 1200V Trench + Field Stop technology
- low switching losses
- soft turn off
- positive temperature coefficient
- easy paralleling

This chip is used for:

• medium power modules



Applications:

medium power drives

Chip Type	V _{CE}	I Cn	Die Size	Package
IGC70T120T6RM	1200V	75A	9.12 x 7.71 mm ²	sawn on foil

MECHANICAL PARAMETER

MEGHANIOAETANAMETEN				
Raster size	9.12 x 7.71	ı		
Emitter pad size (incl. gate pad)	7.61 x 6.24	mm²		
Gate pad size	1.31 x 0.81	min		
Area total / active	70.3 / 51.6			
Thickness	120			
Wafer size	150	mm		
Flat position	90	grd		
Max.possible chips per wafer	200			
Passivation frontside	Photoimide			
Pad metal	3200 nm AlSiCu			
Backside metal	Ni Ag —system suitable for epoxy and soft solder die bonding			
Die bond	Electrically conductive glue or solder			
Wire bond	Al, <500μm			
Reject ink dot size	∅ 0.65mm ; max 1.2mm			
Recommended storage environment	Store in original container, in dry nitrogen, < 6 month at an ambient temperature of 23°C			



MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Collector-Emitter voltage , T _j =25 °C	V _{CE}	1200	V
DC collector current, limited by T _{jmax}	I _C	1)	Α
Pulsed collector current, t _p limited by T _{jmax}	I _{cpuls}	225	Α
Gate-Emitter voltage	V _{GE}	±20	V
Operating junction temperature	T_j	-40 + 175	°C
Short circuit data ²) V _Œ = 15V, V _{CC} = 800V, Tvj = 150°C	tp	10	μs
Reverse bias safe operating area ² (RBSOA)	/ _{CE max} = 1200V, Tvj max	= 150°C	

¹⁾ depending on thermal properties of assembly

STATIC CHARACTERISTICS (tested on wafer), T_j =25 °C

Parameter	Symbol	Conditions	Value			Unit
		Containone	min.	typ.	max.	
Collector-Emitter breakdown voltage	V _{(BR)CES}	V_{GE} =0V , I_{C} = 3 m A	1200			
Collector-Emitter saturation voltage	V _{CE(sat)}	V _{GE} =15V, I _C =75 A	1.6	1.85	2.1	V
Gate-Emitter threshold voltage	V _{GE(th)}	I _C =3mA , V _{GE} =V _{CE}	5.0	5.8	6.5	
Zero gate voltage collector current	I _{CES}	V _{CE} =1200V , V _{GE} =0V			10	μA
Gate-Emitter leakage current	I _{GES}	$V_{CE}=0V$, $V_{GE}=20V$			600	nA
Integrated gate resistor	R _{Gint}			10		Ω

ELECTRICAL CHARACTERISTICS (not subject to production test - verified by design/characterization)

Parameter	Symbol	Conditions	Value			Unit
	- Cynnbon	Conditions	min.	typ.	max.	Oille
Input capacitance	Ciss	V _{CE} =25V,		4400		
Output capacitance	Coss	$V_{GE} = 0V$,		290		pF
Reverse transfer capacitance	C _{rss}	f=1MHz		235		

²⁾ not subject to production test - verified by design/characterization



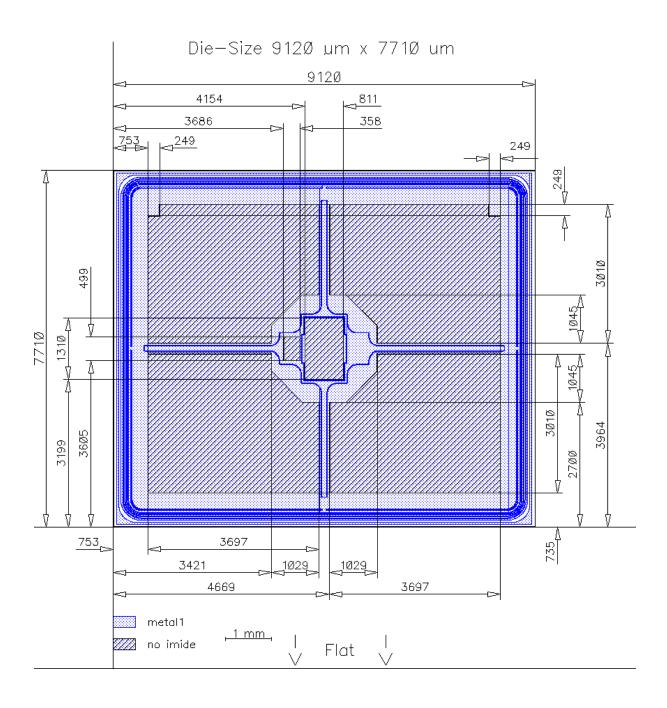
SWITCHING CHARACTERISTICS inductive load (not subject to production test - verified by design /characterization)

Parameter	Symbol	Conditions 1)	Value			Unit
r arameter	Symbol		min.	typ.	max.	Onne
Turn-on delay time	$t_{d(on)}$	T _j =125°C		tbd		
Rise time	t _r	V _{CC} =600V, I _C =75 A,		tbd		ns
Turn-off delay time	$t_{d(off)}$	$V_{GE} = -15/15V$,		tbd		
Fall time	t_{f}	R _G =Ω		tbd		

¹⁾ values also influenced by parasitic L- and C- in measurement and package.



CHIP DRAWING





FURTHER ELECTRICAL CHARACTERISTICS

This chip data sheet refers to the device data sheet	tbd	

DESCRIPTION

AQL 0,65 for visual inspection according to failure catalogue

Electrostatic Discharge Sensitive Device according to MIL-STD 883

Test-Normen Villach/Prüffeld

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